Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination		
10586996	MIYASAKA ET AL.		
Examiner	Art Unit		
HIEN X VO	2863		

SEARCHED				
Class	Subclass	Date	Examiner	
702	33-35/113/183/185	05/08/10	VXH	
318	806	05/08/10	VXH	
	updated search above	8/13/10	VXH	
702	66	08/13/10	VXH	
73	593/650-660	08/13/10	VXH	

SEARCH NOTES			
Search Notes	Date	Examiner	
PLUS	02/26/10	VXH	
consulted with John Le (primary AU 2863)	05/06/10	VXH	
EAST	05/08/10	VXH	
inventors search	05/08/10	VXH	
PLUS	08/13/10	VXH	
EAST	08/13/10	VXH	

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	
702	33/35/113/183/185/66	08/13/10	VXH	
73	593/659/660	08/13/10	VXH	

U.S. Patent and Trademark Office Part of Paper No. : 20100813